

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/722,540	CHO ET AL.	
Examiner		Art Unit		Page 1 of 1
Adam R. Giesy		2627		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,418,091 B1	07-2002	Hirokane et al.	369/13.55
*	B	US-2003/0053400 A1	03-2003	Cho et al.	369/126
*	C	US-6,841,220 B2	01-2005	Onoe et al.	428/66.7
*	D	US-2004/0090903 A1	05-2004	Cho et al.	369/126
*	E	US-2004/0047245 A1	03-2004	Onoe et al.	369/013.01
*	F	US-2004/0042351 A1	03-2004	Onoe et al.	369/013.01
*	G	US-2004/0027935 A1	02-2004	Cho et al.	369/43
*	H	US-2003/0169672 A1	09-2003	Onoe et al.	369/126
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.